

SEi - Radiation Hardened 54HC4046RP

Phase-Locked Loop

54HC4046RP ABSOLUTE MAXIMUM RATINGS 1/ 2/

PARAMETER	SYMBOL	MIN	MAX	UNIT
Supply Voltage	V _{CC}	-0.5	+7.0	V
DC Input Voltage	V _{IN}	-0.5	V _{CC} +0.5	V
DC Output Voltage	V _{OUT}	-0.5	V _{CC} +0.5	V
Clamp Diode Current	I _{IK} , I _{OK}		+20	mA
DC Output Current, per pin	I _{OUT}		+25	mA
DC V _{CC} or GND Current, per pin	I _{CC}		±50	mA
Storage Temperature Range	T _{STG}	-65	+150	°C
Power Dissipation	P _D		500	mW

54HC4046RP OPERATING CONDITIONS

PARAMETER	SYMBOL	MIN	MAX	UNIT
Supply Voltage	V _{CC}	+2.0	+6.0	V
DC Input or Output Voltage	V _{IN} , V _{OUT}	0	V _{CC}	V
Operating Temperature Range	T _A	-55	+125	°C
Input Rise or Fall Times	t _r , t _f			ns
V _{CC} = 2.0V		0	1000	
V _{CC} = 4.5V		0	500	
V _{CC} = 6.0V		0	400	

Note:

1/ Maximum Ratings are those values beyond which damage to the device may occur.

2/ All voltages are referenced to ground, unless otherwise specified.

54HC4046RP DC ELECTRICAL CHARACTERISTICS¹

PARAMETER	SYMBOL	TYP	MAX	UNIT
Minimum High Level Input Voltage V _{CC} = 2.0V V _{CC} = 4.5V V _{CC} = 6.0V	V _{IH}		1.5 3.15 4.2	V
Maximum Low Level Input Voltage V _{CC} = 2.0V V _{CC} = 4.5V V _{CC} = 6.0V	V _{IL}		0.5 1.35 1.8	V
Minimum High Level Output Voltage V _{IN} = V _{IH} or V _{IL} I _{OUT} ≤ 20µA V _{CC} = 2.0V V _{CC} = 4.5V V _{CC} = 6.0V V _{IN} = V _{IH} or V _{IL} I _{OUT} ≤ 4.0mA @ V _{CC} = 4.5V I _{OUT} < 5.2mA @ V _{CC} = 6.0V	V _{OH}	2.0 4.5 6.0	1.9 4.4 5.9	V
Maximum Low Level Output Voltage V _{IN} = V _{IH} or V _{IL} I _{OUT} ≤ 20µA V _{CC} = 3.0V V _{CC} = 4.5V V _{CC} = 6.0V V _{IN} = V _{IH} or V _{IL} I _{OUT} ≤ 4.0mA @ V _{CC} = 4.5V I _{OUT} < 5.2mA @ V _{CC} = 6.0V	V _{OL}		0.1 0.1 0.1 0.4 0.4	V
Input Current V _{IN} = V _{CC} or GND @ V _{CC} = 6.0V Pin 3, 5, 9 Pin 14	I _{IN}		±1.0 100	µA
Maximum Tri-State Output Leakage Current (pin 13) V _{OUT} = V _{CC} or GND @ V _{CC} = 6.0V	I _{OZ}		±10	µA
Maximum Quiescent Supply Current V _{IN} = V _{CC} or GND, I _{OUT} = 0µA, @ V _{CC} = 6.0V V _{IN} = V _{CC} or GND, Pin 14 Open, @ V _{CC} = 6.0V	I _{CC}	30 600	160 3000	µA

Note:

1. For a power supply of 5V ± 10% the worst case output voltages (V_{OH} and V_{OL}) occur at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at V_{CC} = 5.5V and 4.5V respectively. The worst case leakage current (I_{IN}, I_{CC}, and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0V values should be used.



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54HC4046RP AC ELECTRICAL CHARACTERISTICS 2/

PARAMETER	SYMBOL	TYP 3/	MAX	UNIT
AC Coupled Input Sensitivity, Signal In C(series) = 100 pF, $f_{IN} = 500$ kHz $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$			200 250 350	mV
Maximum Output Rise and Fall Time $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	t_r, t_f		110 22 19	ns
PHASE COMPARATOR I				
Maximum Propagation Delay $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	t_{PHL}, t_{PLH}		300 60 51	ns
PHASE COMPARATOR II				
Maximum Tri-State Enable Time $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	t_{PZL}		340 68 57	ns
Maximum Tri-State Enable Time $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	t_{PZH}, t_{PHZ}		360 72 61	ns
Maximum Tri-State Disable Time $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	t_{PLZ}		360 72 61	ns
Maximum Propagation Delay High to Low to Phase Pulses $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	t_{PHL}, t_{PLH}		380 75 64	ns
PHASE COMPARATOR III				
Maximum Propagation Delay $V_{CC} = 2.0V$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	t_{PHL}, t_{PLH}		300 60 51	ns
Maximum Power Dissipation Capacitance All comparators, $V_{IN} = V_{CC}$ and GND	CPD	130		pF
VOLTAGE CONTROLLED OSCILLATOR (operate @ $V_{CC} = 3.0V$ to $6.0V$)				
Maximum Operating Frequency $C_1 = 50pF, R_1 = 100\Omega, R_2 = \infty$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$ $V_{COin} = V_{CC}, C_1 = 0pF, R_1 = 100\Omega, V_{COin} = V_{CC}$ $V_{CC} = 4.5V$ $V_{CC} = 6.0V$	f_{MAX}		7 11 12 14	MHz
Duty Cycle		50		%
DEMODULATOR OUTPUT				
Offset Voltage ($V_{COin} - V_{dem}$) $R_S = 20k\Omega, V_{CC} = 4.5V$			1.6	V
Offset Variation $R_S = 20k\Omega, V_{CC} = 4.5V$ $V_{COin} = 1.75V$ $V_{COin} = 2.25V$ $V_{COin} = 2.75V$		0.65 0.1 0.75		V

Note:

2/ $V_{CC} = 2.0$ to $6.0V, C_L = 50pF, t_r = t_f = 6ns$ (unless otherwise specified).
3/ $T_A = 25^\circ C$.



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54HC4046RP Package Ordering Guide

Package Style	Case Outline	Description
D	D-16	16 Pin Dual In Line Package
F	F-16A	16 Pin Flat Package

Note:

1/ For outline information, see Appendix A (Package Information - Outline Dimension)

54HC4046RP PINOUT

PIN	SIGNAL	DESCRIPTION
1	PHASE PULSES	Phase Comparator Pulse Output
2	PHASE COMP 1 OUT	Phase Comparator 1 Output
3	COMPARATOR IN	Comparator Input
4	VCO OUT	VCO Output
5	INHIBIT	Inhibit Input
6	C1A	Capacitor C1 Connection A
7	C1B	Capacitor C1 Connection B
8	VSS	Ground
9	VCO IN	VCO Input
10	DEMODULATOR OUT	Demodulator Output
11	R1	Resistor R1 Connection
12	R2	Resistor R2 Connection
13	PHASE COMP II OUT	Phase Comparator 2 Output
14	SIGNAL IN	Signal Input
15	PHASE COMP III OUT	Phase Comparator 3 Output
	VDD	Positive Supply Voltage



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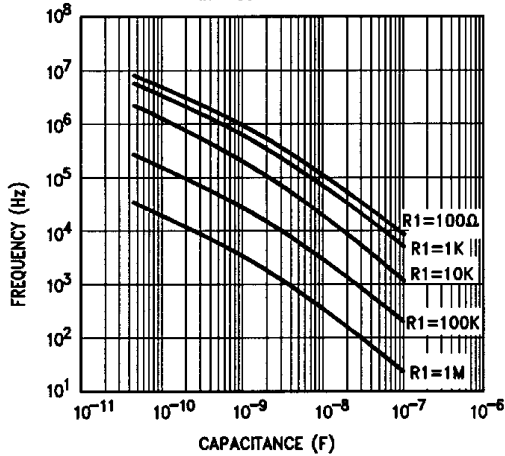
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Phase-Locked Loop

Typical Performance Characteristics

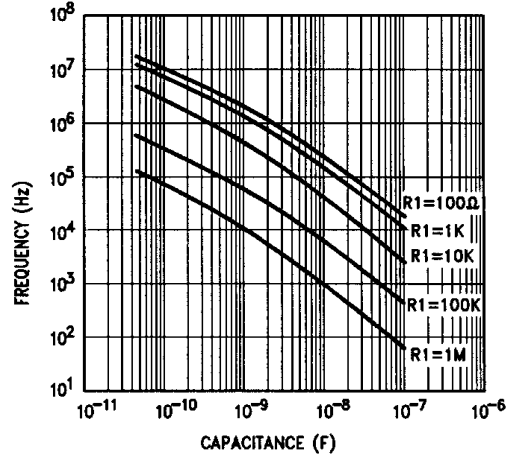
Typical Center Frequency
vs R1, C1 V_{CC} = 4.5V

V_{COIN}=V_{CC}/2 R2=OPEN



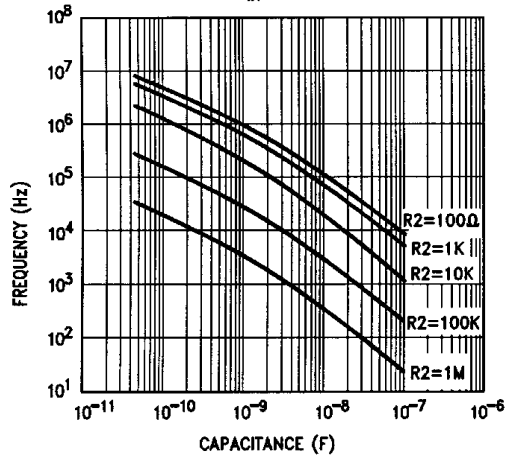
Typical Center Frequency
vs R1, C1 V_{CC} = 6V

V_{COIN}=V_{CC}/2 R2=OPEN



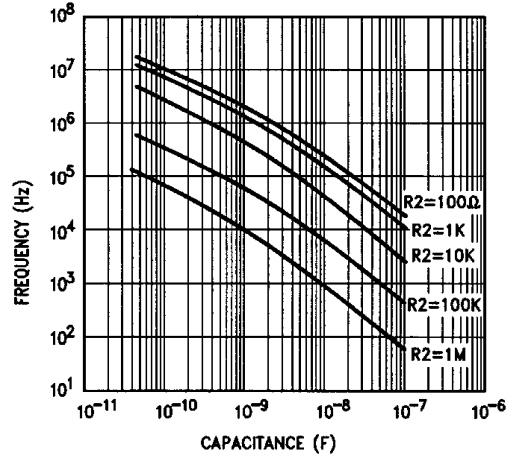
Typical Offset Frequency
vs R2, C1 V_{CC} = 4.5V

T=25°C V_{COIN}=GND R1=OPEN



Typical Offset Frequency
vs R2, C1 V_{CC} = 6V

T=25°C V_{COIN}=GND R1=OPEN



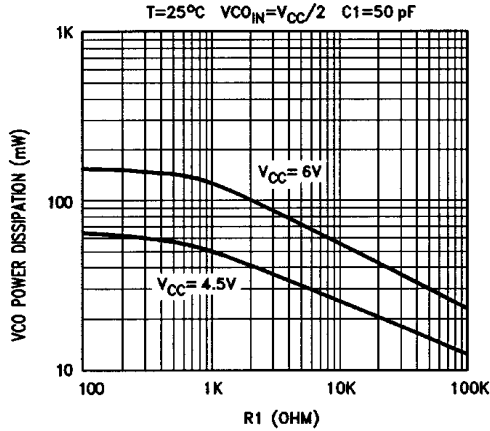
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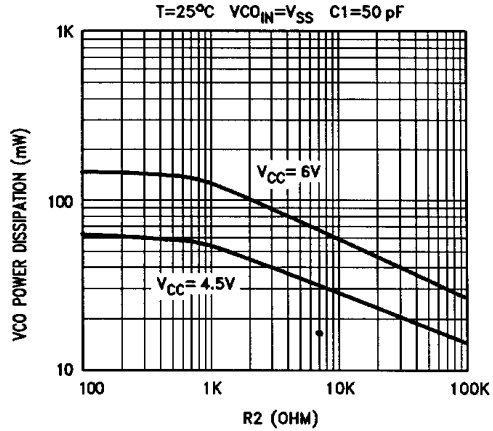
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Typical Performance Characteristics (Continued)

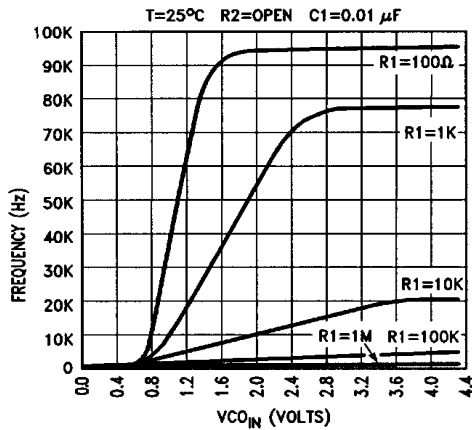
HC4046 Typical VCO Power Dissipation @ Center Frequency vs R1



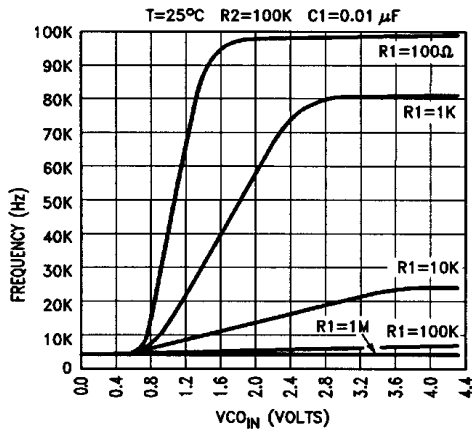
HC4046 Typical VCO Power Dissipation @ f_{min} vs R2



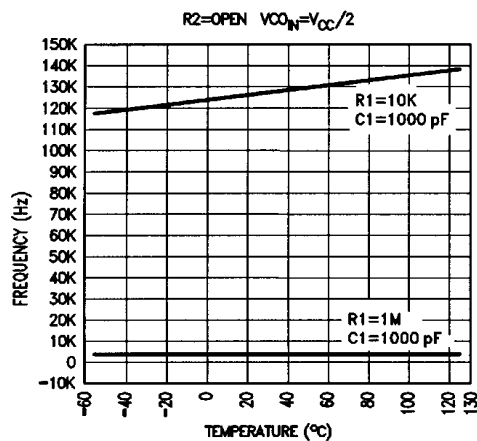
HC4046 VCO_{IN} vs f_{out} V_{CC} = 4.5V



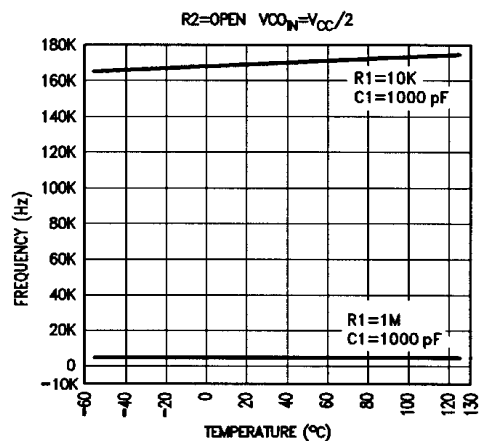
HC4046 VCO_{IN} vs f_{out} V_{CC} = 4.5V



HC4046 VCO_{out} vs Temperature V_{CC} = 4.5V



HC4046 VCO_{out} vs Temperature V_{CC} = 6V



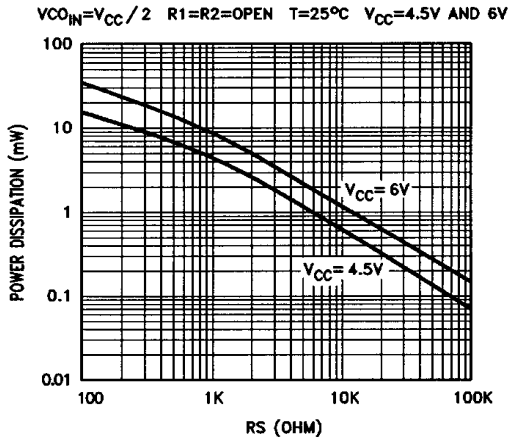
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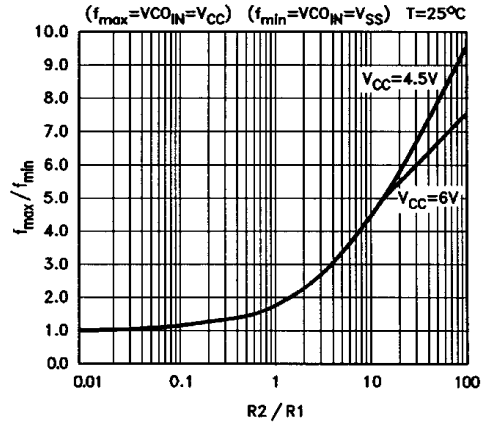
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Typical Performance Characteristics (Continued)

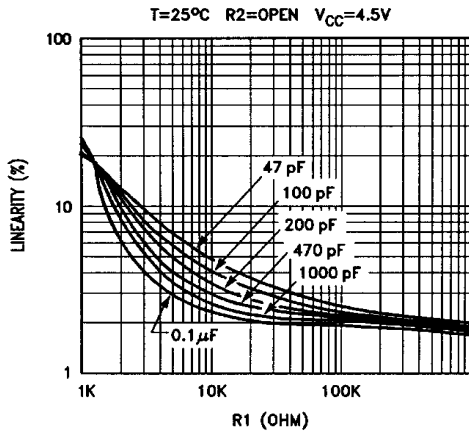
HC4046 Typical Source Follower Power Dissipation vs RS



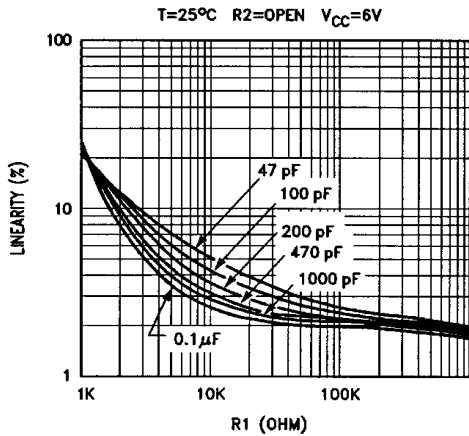
Typical f_{max}/f_{min} vs $R2/R1$
 $V_{CC} = 4.5V$ & $6V$ f_{max}/f_{min}



HC4046 Typical VCO Linearity vs R1 & C1

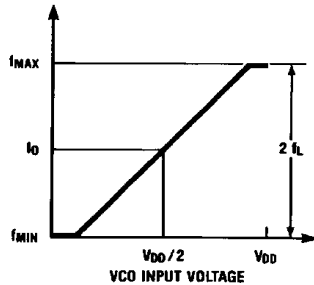


HC4046 Typical VCO Linearity vs R1 & C1

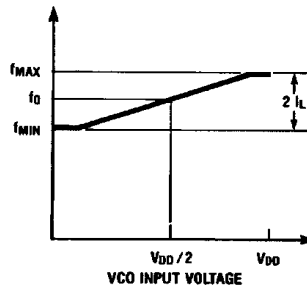


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VCO WITHOUT OFFSET
 $R2 = \infty$



VCO WITH OFFSET



(a)

FIGURE 1

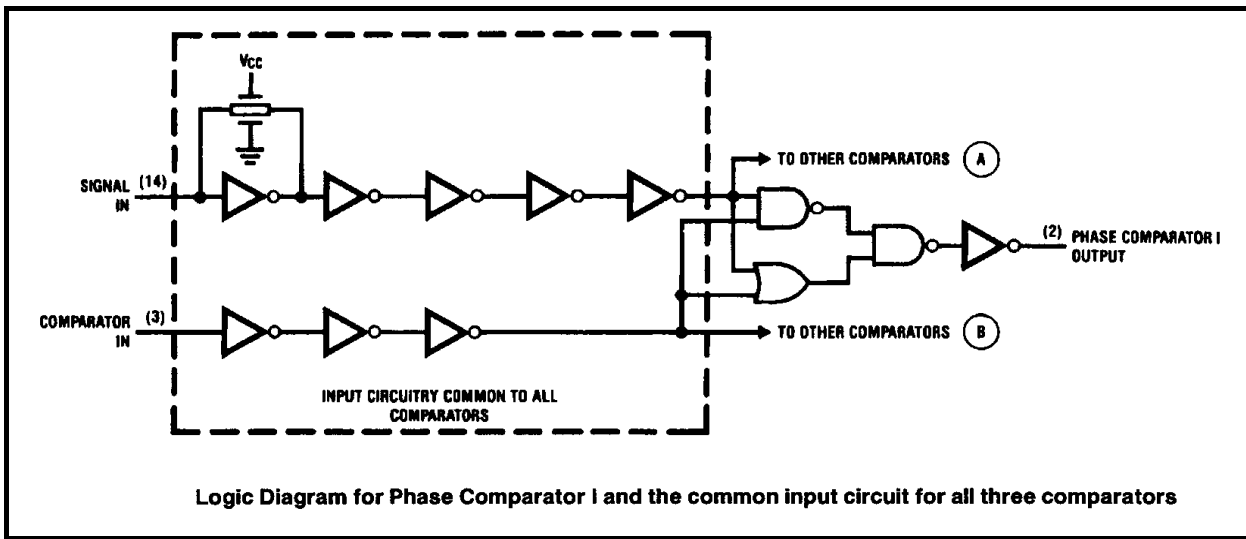
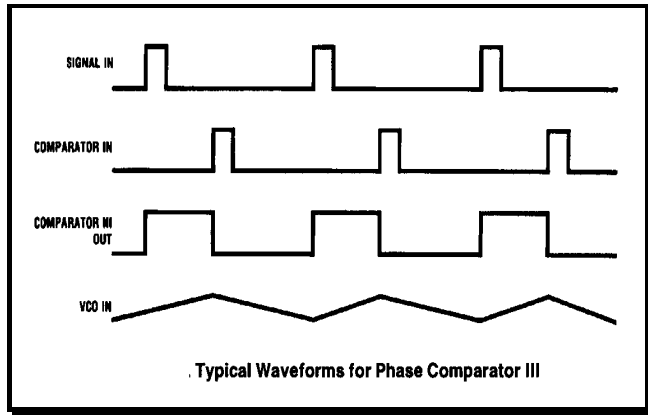
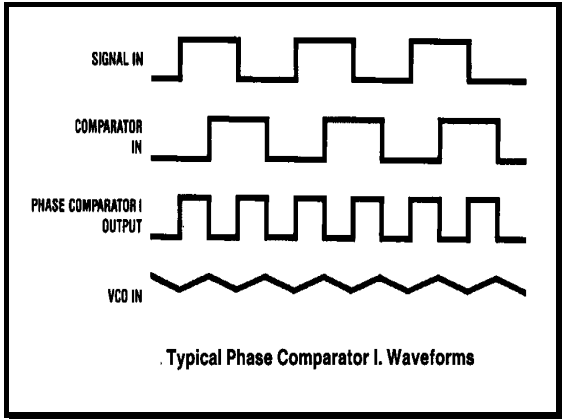
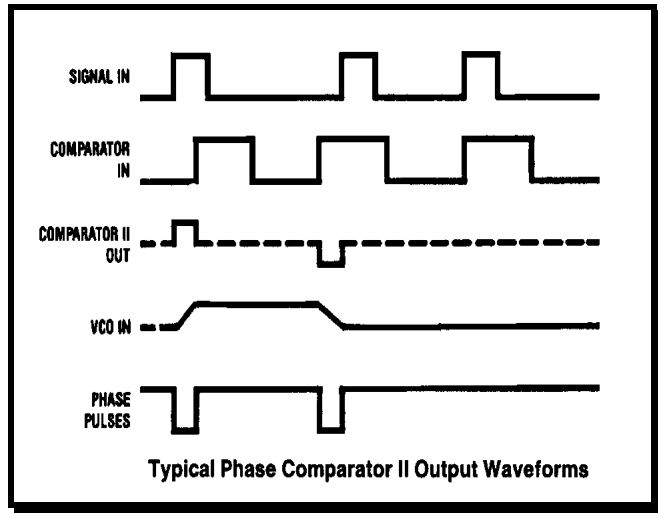
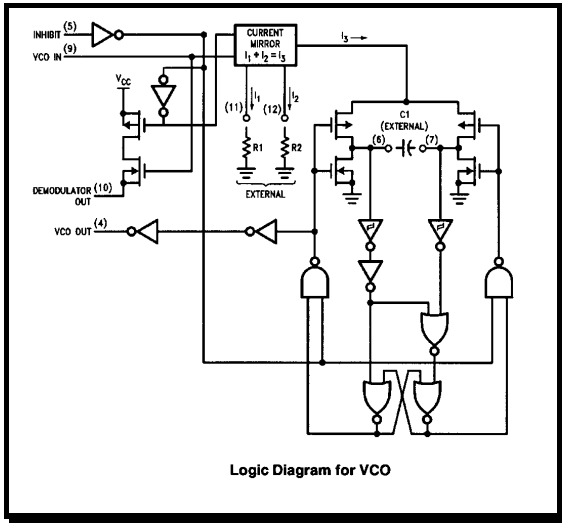


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